

June 2014

FDA20N50F

N-Channel UniFETTM FRFET[®] MOSFET 500 V, 22 A, 260 m Ω

Features

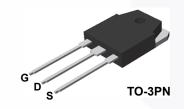
- $R_{DS(on)}$ = 220 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 11 A
- Low Gate Charge (Typ. 50 nC)
- Low C_{rss} (Typ. 27 pF)
- · 100% Avalanche Tested
- · Improved dv/dt Capability
- · RoHS Compliant

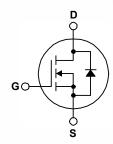
Applications

- PDP TV
- · Uninterruptible Power Supply
- · AC-DC Power Supply

Description

UniFETTM MOSFET is Fairchild Semiconductor's high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. The body diode's reverse recovery performance of UniFET FRFET® MOSFET has been enhanced by lifetime control. Its trr is less than 100nsec and the reverse dv/dt immunity is 15V/ns while normal planar MOSFETs have over 200nsec and 4.5V/nsec respectively. Therefore, it can remove additional component and improve system reliability in certain applications in which the performance of MOSFET's body diode is significant. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		Parameter		FDA20N50F	Unit
V _{DSS}	Drain to Source Voltage			500	V
V _{GSS}	Gate to Source Voltage			±30	V
	Drain Current	- Continuous (T _C = 25°C)		22	^
ID	Diamounent	- Continuous (T _C = 100°C)		13	Α
I _{DM}	Drain Current	- Pulsed	(Note 1)	88	Α
E _{AS}	Single Pulsed Avalanche E	nergy	(Note 2)	1110	mJ
I _{AR}	Avalanche Current		(Note 1)	22	Α
E _{AR}	Repetitive Avalanche Ener	gy	(Note 1)	39	mJ
dv/dt	Peak Diode Recovery dv/d	t	(Note 3)	20	V/ns
D	Dawer Dissination	(T _C = 25°C)		388	W
P_{D}	Power Dissipation	- Derate above 25°C		3.1	W/°C
T _J , T _{STG}	Operating and Storage Ter	nperature Range		-55 to +150	°C
T _L	Maximum Lead Temperatu 1/8" from Case for 5 Secon	• •		300	°C

Thermal Characteristics

Symbol	Parameter FDA2		Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.44	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	

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Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDA20N50F	FDA20N50F	TO-3PN	Tube	N/A	30 units

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	teristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu A, V_{GS} = 0V, T_J = 25^{\circ}C$	500	-	-	V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.6	-	V/°C
1	Zero Gate Voltage Drain Current	V _{DS} = 500V, V _{GS} = 0V	-	-	10	μА
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 400V, T_{C} = 125^{\circ}C$	-	-	100	μΑ
I_{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10V, I _D = 11A	-	0.22	0.26	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40V, I _D = 11A	-	24	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V - 25V V - 0V		-	2550	3390	pF
C _{oss}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz		-	350	465	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	Ī	-\	27	40	pF
Q _{g(tot)}	Total Gate Charge at 10V			-	50	65	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 400V, I_{D} = 20A$	İ	-	14	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V	(Note 4)	-	20	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			-	45	100	ns
t _r	Turn-On Rise Time	$V_{DD} = 250V, I_{D} = 20A$		-	120	250	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25\Omega$		-	100	210	ns
t _f	Turn-Off Fall Time		(Note 4)	-	60	130	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	22	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Fo	orward Current	-	-	88	Α
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 22A$	-	-	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 20A	-	154	-	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt = 100A/μs	-	0.5	-	μС

- $\label{eq:Notes:Notes:Notes:} \begin{tabular}{ll} \textbf{Notes:} \\ 1: & \textbf{Repetitive Rating: Pulse width limited by maximum junction temperature} \\ 2: & \textbf{L} = 5\text{mH, I}_{AS} = 20\text{A, V}_{DD} = 50\text{V, R}_{G} = 25\Omega, \textbf{Starting T}_{J} = 25^{\circ}\text{C} \\ 3: & \textbf{I}_{SD} \leq 22\text{A, di/dt} \leq 200\text{A/µs, V}_{DD} \leq \text{BV}_{DSS}, \textbf{Starting T}_{J} = 25^{\circ}\text{C} \\ 4: & \textbf{Essentially Independent of Operating Temperature Typical Characteristics} \\ \end{tabular}$



Typical Characteristics

Figure 1. On-Region Characteristics

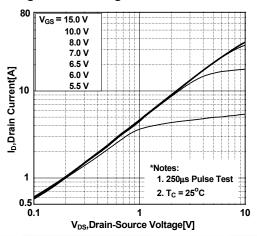


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

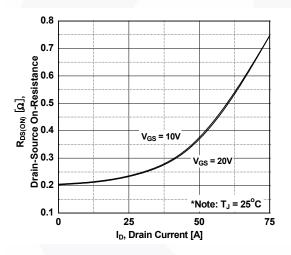


Figure 5. Capacitance Characteristics

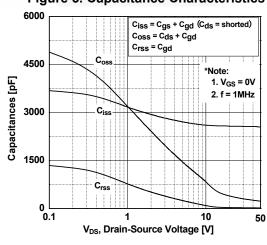


Figure 2. Transfer Characteristics

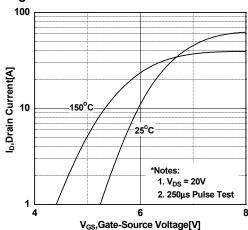


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

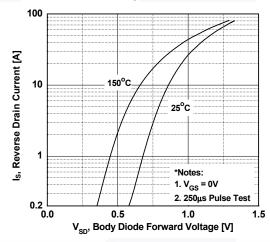
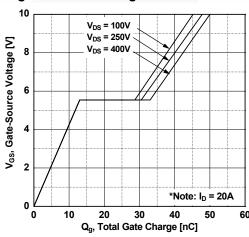


Figure 6. Gate Charge Characteristics



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Typical Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

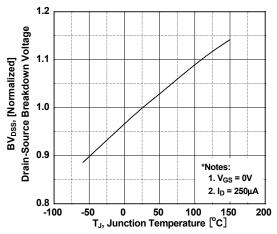


Figure 8. Maximum Safe Operating Area

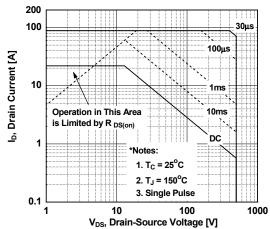


Figure 9. Maximum Drain Current vs. Case Temperature

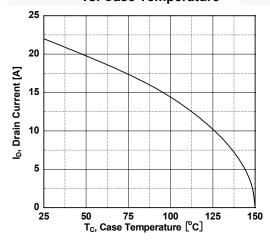
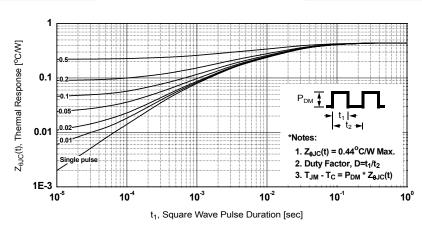


Figure 10. Transient Thermal Response Curve



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Figure 11. Gate Charge Test Circuit & Waveform

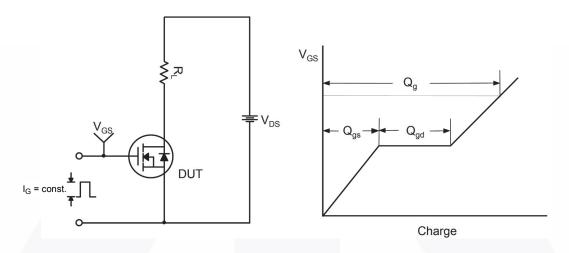


Figure 12. Resistive Switching Test Circuit & Waveforms

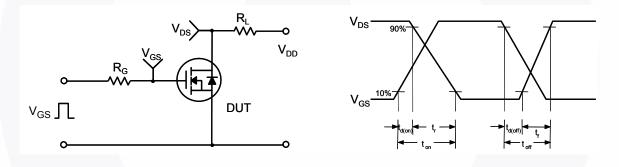
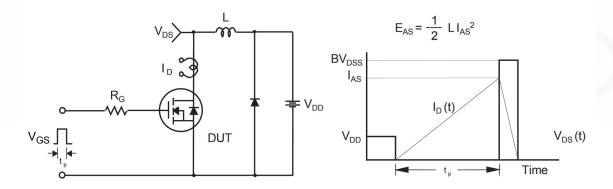
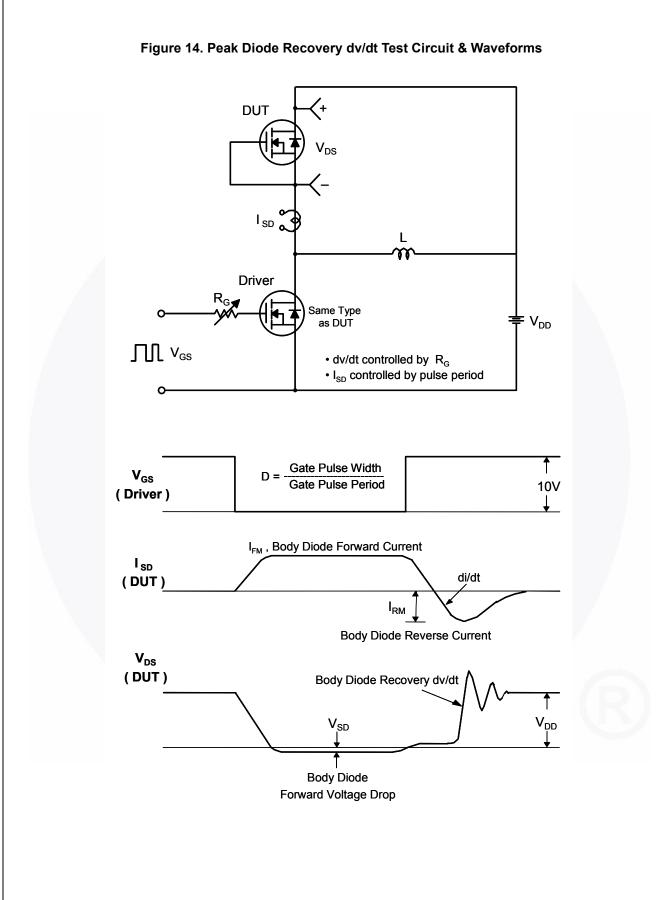


Figure 13. Unclamped Inductive Switching Test Circuit & Waveforms



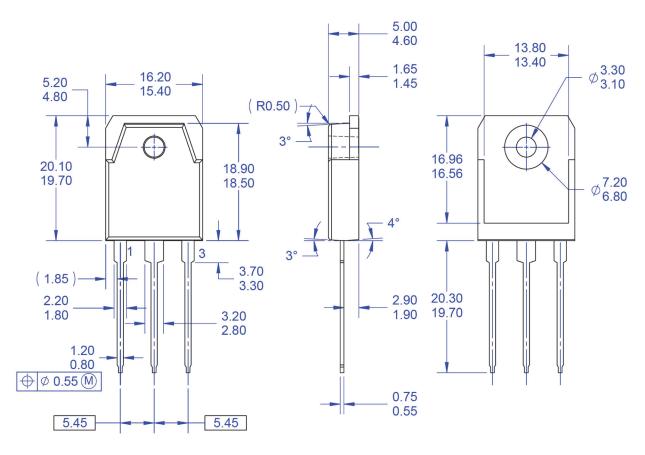


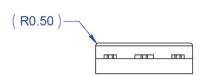
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Mechanical Dimensions





NOTES: UNLESS OTHERWISE SPECIFIED

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 E) DRAWING FILE NAME: TO3PN03AREV1.
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Figure 15. TO3PN, 3-Lead, Plastic, EIAJ SC-65

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